

<b>Notice of References Cited</b>	Application/Control No. 10/052,890	Applicant(s)/Patent Under Reexamination SNEH, OFER	
	Examiner Eric B Fuller	Art Unit 1762	Page 1 of 1

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**NON-PATENT DOCUMENTS**

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	U	Kattelus et al. VTT ELECTRONICS - RESEARCH ACTIVITIES IN MICROELECTRONICS 1998, pages 14-15.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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